

Search Notes	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10826090	CHEN, SHI-SHIEN
	Examiner Neway, Samuel G	Art Unit 2626

SEARCHED			
Class	Subclass	Date	Examiner
704	8 (with text)	01/22/08	SN
341	50-107 (with text)	01/31/08	SN

SEARCH NOTES			
Search Notes	Date	Examiner	
EAST: Text, Assignee, Inventor, Forward & Backward, and PLUS Search	08/14/07	SN	
Consulted: P. Edouard	08/14/07	SN	
Consulted: T. Smits	08/15/07	SN	
Updated EAST Search	01/22/08	SN	
STIC Search	01/30/08	SN	
Consulted: P. Harper	01/29/08	SN	
EAST: Updated Search	05/15/08	SN	

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
704	8	05/15/08	SN
341	50	05/15/08	SN